

## Description

# A Muxed-Output Double-Data-Rate-2 (DDR2) Register with Fast Propagation Delay

### CROSS REFERENCE TO RELATED APPLICATIONS

[0001] This application is a continuation-in-part of the co-pending application for "Data Register for Buffering Double-Data-Rate DRAMs with Reduced Data-Input-Path Power Consumption", U.S. Ser. No. 10/249,581, filed 4/21/03.

### BACKGROUND OF INVENTION

[0002] This invention relates to integrated circuits, and more particularly to differential buffer chips.

[0003] Memory modules are widely used in electronic systems such as personal computers (PCs). Various standards are used, such as those by the Joint Electronic Device Engineering Council (JEDEC). Some JEDEC standards use double-data-rate (DDR) dynamic-random-access memory

(DRAM) chips on modules known as dual-in-line-memory-modules (DIMMs). A newer DDR-2 standard is also being implemented. Differential input signals are used for faster signaling.

[0004] Very high-speed buffer chips are needed for interfacing with the DDR-2 DRAM's. Each data line, and perhaps some address or control signals are buffered. Bi-directional data lines can be supported by using two uni-directional data-buffer slices in parallel but in reverse directions.

[0005] Figure 1 shows a bit-slice for a data buffer chip that interfaces with DDR-2 DRAMs. Data inputs D1, D2 are some of 25 or so data lines input to a buffer chip. Data input D1 is compared to a reference voltage  $V_{ref}$  by differential buffer 12, then applied to the D-input of flip-flop 20. Likewise, data input D2 is compared to reference voltage  $V_{ref}$  by differential buffer 14, then applied to the D-input of flip-flop 22.  $V_{ref}$  is a reference voltage such as  $V_{cc}/2$ .

[0006] The Q1 output of inverting buffer 16 is a latched data bit that can be applied to one of the DDR-2 DRAM's data inputs. The Q2 output of inverting buffer 18 is another latched data bit that can be applied to another one of the DDR-2 DRAM's data inputs.

[0007] When SEL is low, mux 24 selects the upper input, causing

Q1 to be driven from the latched D1 from flip-flop 20.

When SEL is high, mux 24 selects its lower input, causing Q1 to be driven from the latched D2 from flip-flop 22. SEL can be a mode signal that is low to indicate 1:2 mode, but high to indicate 1:1 mode. In 1:1 mode, two different outputs are generated from two different inputs, but in 1:2 mode two outputs are generated from the same (D2) input.

[0008] Clock buffer 26 receives a differential clock CK and CKB, and generates a clock edge to flip-flops 20, 22 when the differential clock signals cross-over. Reset signal RST can be applied to differential buffers 12, 14, clock buffer 26, and flip-flops 20, 22.

[0009] While such a data buffer is useful, an added clock-to-output propagation delay occurs for the Q1 data, which passes through mux 24 compared with the Q2 data that does not have to be delayed by mux 24. Mux 25 may include transmission gates and inverter buffers needed to re-generate signals that are reduced in strength by the effective resistance of the transmission gates.

[0010] Since tight delay times are specified by the JEDEC standard, the data-path delay may have to be reduced, such as by using a higher-speed buffer 16 or larger-

drive-current transistors in mux 24. However, increasing the speed of buffer 16 requires a large current, which increases power consumption. Since there can be as many as 25 bit slices such as shown in Fig. 1 in a buffer chip, a large overall power consumption can occur. Such large power consumptions are undesirable.

[0011] What is desired is a buffer chip with lower power dissipation. A faster clock-to-output data output path from the flip-flop is desirable without relying on large-current differential input buffers.

#### **BRIEF DESCRIPTION OF DRAWINGS**

[0012] Figure 1 shows a bit-slice for a data buffer chip that interfaces with DDR-2 DRAMs.

[0013] Figure 2 shows a 2-bit slice of a buffer chip with a reduced clock-to-output delay by integration of the output data mux with the flip-flops.

[0014] Figure 3 is a schematic of a muxing flip-flop with different inputs.

[0015] Figure 4 is a schematic of a muxing flip-flop with identical inputs.

[0016] Figure 5 is an alternate embodiment with differential clocks.

[0017] Figure 6 shows a muxing flip-flop that has differential

clocks as inputs.

[0018] Figure 7 is a schematic of a muxing flip-flop that has differential clocks as inputs and the same data input.

#### **DETAILED DESCRIPTION**

[0019] The present invention relates to an improvement in buffer chips. The following description is presented to enable one of ordinary skill in the art to make and use the invention as provided in the context of a particular application and its requirements. Various modifications to the preferred embodiment will be apparent to those with skill in the art, and the general principles defined herein may be applied to other embodiments. Therefore, the present invention is not intended to be limited to the particular embodiments shown and described, but is to be accorded the widest scope consistent with the principles and novel features herein disclosed.

[0020] The inventor has realized that clock-to-output data path delays can be reduced if the output mux can be eliminated. Since the mux is in the critical path, removal of the mux can reduce propagation delays and allow for smaller buffers to be used for the data output path. The smaller buffers can result in a significant power reduction since one buffer is needed for each of the 25 or so data input

slices. The multiplexing function can be integrated with the flip-flops so that the inputs to the flip-flops are muxed rather than their outputs.

[0021] While the mux could simply be moved to before the flip-flop inputs, this could cause a different problem. The additional mux delay before the flip-flop could cause an increase in the data set-up time to the flip-flop. Thus simply moving the mux may not solve all problems. Rather than move the mux, the inventor merges the muxing function with the flip-flop itself.

[0022] Figure 2 shows a 2-bit slice of a buffer chip with a reduced clock-to-output delay by integration of the output data mux with the flip-flops. Differential input buffers 12, 14 compare data inputs D1P, D2P to reference voltage Vref to generate single-ended data inputs D1, D2 when reset RST is not active.

[0023] The single-ended data inputs D1, D2 are input to muxing flip-flops 40. Muxing flip-flops 40 have an input mux to the master stage, allowing either one of the two data inputs D1, D2 to be latched into the master. The slave stage does not need muxing logic and can efficiently drive the output.

[0024] The Q1P output is generated by inverting buffer 16, which

directly receives the Q1 output of muxing flip-flops 40, eliminating the output mux delay of Fig. 1. Likewise, the Q2P output is generated by buffer 18, which directly receives the Q2 output of muxing flip-flops 40.

[0025] To implement the desired DDR-2 output-muxing scheme, the Q1 output of muxing flip-flops 40 can be driven by a muxed-input flip-flop that receives both D1 and D2, while the Q2 output is driven by a standard flip-flop with a single input, D2. Alternately, the Q2 output can be driven by a muxed-input flip-flop that has D2 as both inputs to the mux. Signal delays can be better matched when both Q1 and Q2 data paths are similar.

[0026] Clocking of muxing flip-flops 40 is more complex than of a standard flip-flop. Three clocks are used. Clock buffer 30 generates a clock edge of DCK to muxing flip-flops 40 when differential clock signals CK, CKB cross-over. DCK is a free-running clock that clocks the slave stages in muxing flip-flops 40.

[0027] While slave-stage clock DCK is always running, only one of master clocks CK1:2 and CK1:1 is running at a time, depending on the mode. For 1:1 mode, master-stage clock CK1:1 pulses, while clock CK1:2 is static, non-pulsing. For 1:2 mode, master-stage clock CK1:2 pulses,

while clock CK1:1 is static, non-pulsing.

[0028] Clock CK1:1 clocks in data from one of the two inputs to the muxed-input flip-flop, while clock CK1:2 clocks in data from the other of the two inputs to the muxed-input flip-flop in muxing flip-flops 40. Thus the mode, 1:1 or 1:2, determines which of clocks CK1:1 or CK1:2 is pulsing, and which of the two muxed data inputs is active and which is disabled. Thus the muxing function is controlled by clocks CK1:1, CK1:2.

[0029] Clock buffers 32, 34 receive the reset signal RST and a mode select signal SEL, or the inverse of SEL. When SEL is high, mode 1:2 is selected. The high SEL disables clock buffer 34, disabling clock CK1:1, while inverter 10 drives a low to the reset input of clock buffer 32, allowing clock CK1:2 to pulse.

[0030] When SEL is low, mode 1:1 is selected. The low SEL enables clock buffer 34, allowing clock CK1:1 to pulse, while inverter 10 drives a high to the reset input of clock buffer 32, disabling clock CK1:2. When reset RST is active, all clock buffers 30, 32, 34 are disabled from pulsing. Clock buffers 30, 32, 34 each generate a clock edge to muxing flip-flops 40 when differential clock signals CK, CKB cross-over and when its reset input is inactive (low).



[0031] Figure 3 is a schematic of a muxing flip-flop with different inputs. Muxing flip-flops 40 of Fig.3 can include the muxed-input flip-flop that latches in either D1 or D2 and drives the Q1 output, and the muxed-input flip-flop that latches in only D2 and drives the Q2 output, shown in Fig. 4.

[0032] All clocks are generated from input clock CK, as shown in Fig. 5. When the input clock CK is high, the master stage feeds back while the slave stage latches the master data. When the input clock CK is low, the slave stage feeds back while the master stage samples either input data D1 or D2.

[0033] Slave clock DCK is inverted first by inverter 74 to generate DCKB, then inverted again by inverter 80 to generate DCKC. The slave clock pulses in both 1:1 and 1:2 modes. First master clock CK1:1 pulses high and low in 1:1 mode but is held high (inactive) in 1:2 mode. Inverter 78 inverts CK1:1 to generate CK1:1B, and inverter 84 re-inverts CK1:1B to generate CK1:1C. Second master clock CK1:2 pulses high and low in 1:2 mode but is held high (inactive) in 1:1 mode. Inverter 76 inverts CK1:2 to generate CK1:2B, and inverter 82 re-inverts CK1:2B to generate CK1:2C. Inverter 72 inverts reset signal RST to generate

RSTB.

- [0034] The slave stage has a first transmission gate of transistors 60, 62 which are opened when DCK is high and DCKB is low. The feedback path is interrupted by transistors 66, 68 which conduct in the opposite clock state, when DCK is low. The output of transmission gate transistors 60, 62 is input to NOR gate 70, which drives feedback to p-channel transistor 64, which is in series with p-channel transistor 66, and n-channel transistor 69, which is in series with n-channel transistor 68. The Q1 output is taken from the output of transmission gate transistors 60, 62, which is also the drains of feedback transistors 66, 68.
- [0035] The master stage has two input transmission gates, and two pairs of feedback transistors to perform the muxing function. One transmission gate is opened and closed by a clock, while the other transmission gate remains closed while its feedback transistors remain on.
- [0036] The first transmission gate includes transmission gate transistors 50, 58 and inputs D1 to the master stage when clock CK1:1 pulses low. The second transmission gate includes transmission gate transistors 52, 54 and inputs D2 to the master stage when clock CK1:2 pulses low. Either clock CK1:1 pulses and clock CK1:2 remains high, when

1:1 mode is selected, or clock CK1:2 pulses and clock CK1:1 remains high, when 1:2 mode is selected. Thus the master stage samples only one input, D1 or D2, depending on the mode selected.

[0037] The master-stage output is taken from inverter 56 and drives the transmission gate into the slave stage. Feedback data within the master stage from inverter 56 is applied to the gates of p-channel transistor 42 and n-channel transistor 49.

[0038] A feedback gate includes p-channel transistors 42, 44, 45 and n-channel transistors 46, 48, 49 in series. The feedback gate drives the input of inverter 56. When the input clock CK is high, both CK1:1C and CK1:2C are high, causing n-channel transistors 46, 48 to conduct. Likewise, when input clock CK is high, both CK1:1B and CK1:2B are low, causing p-channel transistors 44, 45 conduct. When the output of inverter 56 is high, n-channel feedback transistor 49 is on and p-channel feedback transistor 42 is off, driving the input of inverter 56 low. When the output of inverter 56 is low, n-channel feedback transistor 49 is off and p-channel feedback transistor 42 is on, driving the input of inverter 56 high. The data applied to feedback transistors 42, 49 is thus inverted during recycling.

[0039] The feedback gate stops conducting when input clock CK is low, since either CK1:1C or CK1:2C is low, turning off n-channel transistor 48 or 46, respectively, and either CK1:1B or CK1:2B is high, turning off p-channel transistor 44 or 45, respectively.

[0040] In 1:1 mode, data input D1 passes through first transmission gate transistors 50, 58 when CK1:1B pulses high, and is inverted by inverter 56 and later latched into the slave stage when DCK goes low. Output Q1 is thus driven from input D1. This is the 1:1 mode. CK1:2B remains low in 1:1 mode, so second transmission gate transistors 52, 54 remain off as the primary clock CK pulses. Second feedback transistors 45, 46 remain on. Data is fed back from inverter 56 to p-channel transistor 42 and n-channel transistor 49, and is recycled to the input of inverter 56 when CK1:1B pulses low, and first feedback transistors 44, 48 turn on.

[0041] In 1:2 mode, data input D2 passes through second transmission gate transistors 52, 54 when CK1:2B pulses high, and is inverted by inverter 56 and later latched into the slave stage when DCK goes low. Output Q1 is driven from input D2. This is the 1:2 mode. CK1:1B remains low in 1:2 mode, so first transmission gate transistors 50, 58 remain

off as the primary clock CK pulses. First feedback transistors 44, 48 remain on. Data is fed back from inverter 56 to p-channel transistor 42 and n-channel transistor 49, and is recycled to the input of inverter 56 when CK1:2B pulses low, and second feedback transistors 45, 46 turn on.

[0042] Figure 4 is a schematic of a muxing flip-flop with identical inputs. Both the first transmission gate (transistors 150, 158) and the second transmission gate (transistors 152, 154) are connected to data input D2. Thus regardless of whether 1:1 or 1:2 mode is selected, data input D2 is latched to generate output Q2 from the drains of transistors 166, 168 in the slave stage.

[0043] Otherwise, the structure and operation is similar to that described for Fig. 3. Delay to output Q2 are similar to delays for output Q1 since the structure of the flip-flop of Fig. 4 is so similar to the structure of the flip-flop of Fig. 3. Such delay matching may be beneficial in some applications. Alternately, a standard flip-flop could be used for latching D2 to generate Q2, replacing the circuit of Fig. 4.

[0044] When reset RST is high, NOR gate 170 drives its output low. This causes Q2 to go high, which is inverted by inverter 18 (Fig. 2) to drive the final Q2 output low during

reset.

[0045] Figure 5 is an alternate embodiment with differential clocks. Differential may be originally input to the register chip. Differential signaling can continue into the chip to the transmission gates of the muxing flip-flops. Fig. 5 is similar to Fig. 3, except that differential clocks are output from clock buffers 130, 132, 134 and input to muxing flip-flops 140 as differential clocks.

[0046] For example, clock buffer 130 receives input clock CK, CKB and generates DCK, DCKN that are input to muxing flip-flops 140. Clock buffer 132 also receives differential input clock CK, CKB and generates CK1:2, CK1:2N, while clock buffer 134 receives input clock CK, CKB and generates CK1:1, CK1:1N.

[0047] Muxing flip-flops 140 receive a pair of complementary signals for each clock. While slave clocks DCK, DCKN continuously pulse in both 1:1 and 1:2 modes, master clocks CK1:1, CK1:1N pulse only in 1:1 mode, while CK1:1 stays high and CK1:1N stays low in 1:2 mode. Similarly, master clocks CK1:2, CK1:2N pulse only in 1:2 mode, while CK1:2 stays high and CK1:2N stays low in 1:1 mode.

[0048] Figure 6 shows a muxing flip-flop that has differential clocks as inputs. Inverter 274 generates DCKB from posi-

tive differential clock DCK, while inverter 276 generates DCKNB from negative differential clock DCKN. DCKNB is applied to the gates of n-channel transmission gate transistor 260 and p-channel feedback transistor 266 in the slave stage, while DCKB is applied to the gates of p-channel transmission gate transistor 262 and n-channel feedback transistor 268 in the slave stage. The slave's input transmission gate is thus turned on when DCK and DCKNB are high, and DCKB is low.

[0049] Inverter 282 generates CK1:1B from positive differential clock CK1:1, while inverter 284 generates CK1:1NB from negative differential clock CK1:1N. CK1:1B is applied to the gates of n-channel transmission gate transistor 250 and p-channel feedback transistor 244 in the master stage to sample D1, while CK1:1NB is applied to the gates of p-channel transmission gate transistor 258 and n-channel feedback transistor 248 in the master stage. The master's D1 input transmission gate is thus turned on when CK1:1 and CK1:1NB are low, and CK1:1B is high.

[0050] Inverter 278 generates CK1:2B from positive differential clock CK1:2, while inverter 280 generates CK1:2NB from negative differential clock CK1:2N. CK1:2B is applied to the gates of n-channel transmission gate transistor 252

and p-channel feedback transistor 245 in the master stage to sample D2, while CK1:2NB is applied to the gates of p-channel transmission gate transistor 254 and n-channel feedback transistor 246 in the master stage. The master's D2 input transmission gate is thus turned on when CK1:2 and CK1:2NB are low, and CK1:2B is high.

[0051] Operation is otherwise similar to that described earlier for the circuit of Fig. 4. Figure 7 is a schematic of a muxing flip-flop that has differential clocks as inputs and the same data input. Data input D2 is applied to both the first transmission gate of transistors 350, 358, and to the second transmission gate of transistors 352, 354. Thus in both 1:1 and 1:2 modes, data D2 is sampled to generate Q2 from the slave stage.

[0052] Having differential clocks propagated through the muxing flip-flops can improve performance. For the worst-case clocks, one less inverter delay is needed when differential internal clocks are used, as in Figs. 5–7, compared with the single-ended clocks of Figs. 2–4. DCKC requires the clock buffer 30 plus two inverters 74, 80 (Figs 2, 3), while DCKNB requires clock buffer 130 plus only one inverter 276 (Figs 5, 6). Thus one inverter delay is saved using full differential clocking.



## [0053] ALTERNATE EMBODIMENTS

[0054] Several other embodiments are contemplated by the inventor. For example, different buffering, gating, and logic may be substituted. Inverters, NAND or NOR gates could be added to the clock or data buffers, or these gates can be replaced with other logic such as transmission gates and buffers or switch networks. Signals can be active high or active low.

[0055] Clocks could be free-running and yet still be disabled for power-saving or other disabling modes. Clocks could be free-running for shorter periods of time, such as when data is being transferred to or from the DRAM chips, while the clocks are disabled for other periods of time when the DRAM is not being accessed. The reset signals could be activated for these non-access time periods, or other disabling or power-down signals could be used. Global or local or some combination of buffering and inverting can be used.

[0056] The master and slave stages could be set or reset by adding various logic gates. For example, the slave can be set to 1 by a NOR gate 70 and an inverter, using an active-high reset to the NOR gate, or reset to 0 using a NAND gate with an active-low reset that replaces the

NAND gate. The master stage could be set or reset in a similar manner by changing inverter 56 to a NAND or NOR gate. Keeper or leaker transistors could be added, as could capacitors and resistors or other passive components. Inverters and buffers could be added to the output, and multiple outputs or differential outputs could be generated. The muxing flip-flops 40 invert the data input, but a non-inverting flip-flop could be constructed by taking the output Q1 from the output of NOR gate 70 rather than from the input of NOR gate 70.

[0057] Any advantages and benefits described may not apply to all embodiments of the invention. When the word "means" is recited in a claim element, Applicant intends for the claim element to fall under 35 USC Sect. 112, paragraph 6. Often a label of one or more words precedes the word "means". The word or words preceding the word "means" is a label intended to ease referencing of claims elements and is not intended to convey a structural limitation. Such means-plus-function claims are intended to cover not only the structures described herein for performing the function and their structural equivalents, but also equivalent structures. For example, although a nail and a screw have different structures, they are equivalent structures

since they both perform the function of fastening. Claims that do not use the word "means" are not intended to fall under 35 USC Sect. 112, paragraph 6. Signals are typically electronic signals, but may be optical signals such as can be carried over a fiber optic line.

[0058] The foregoing description of the embodiments of the invention has been presented for the purposes of illustration and description. It is not intended to be exhaustive or to limit the invention to the precise form disclosed. Many modifications and variations are possible in light of the above teaching. It is intended that the scope of the invention be limited not by this detailed description, but rather by the claims appended hereto.